SGS-THOMSON MICROELECTRONICS

BUZ71A

N - CHANNEL ENHANCEMENT MODE POWER MOS TRANSISTOR

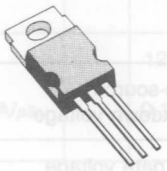
TYPE	V_{DSS}	$R_{DS(on)}$	I_D
BUZ71A	50 V	0.12 Ω	13 A

- ULTRA FAST SWITCHING
- LOW DRIVE ENERGY FOR EASY DRIVE
- COST EFFECTIVE

INDUSTRIAL APPLICATIONS:

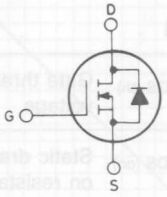
- AUTOMOTIVE POWER ACTUATORS
- MOTORS CONTROL
- INVERTERS

N - channel enhancement mode POWER MOS field effect transistor. Easy drive and very fast switching times make this POWER MOS transistor ideal for high speed switching applications such as power actuator driving, motor drive including brushless motors, hydraulic actuators and many other uses in automotive and automotive and automatic guided vehicle applications. It also finds use in DC/DC converters and uninteruptable power supplies.



TO-220

INTERNAL SCHEMATIC DIAGRAM



ABSOLUTE MAXIMUM RATINGS

V_{DS}	Drain-source voltage ($V_{GS} = 0$)	50	V
V_{DGR}	Drain-gate voltage ($R_{GS} = 20$ KΩ)	50	V
V_{GS}	Gate-source voltage	±20	V
I_D	Drain current (continuous) $T_c = 25°C$	13	A
I_{DM}	Drain current (pulsed)	52	A
P_{tot}	Total dissipation at $T_c < 25°C$	40	W
T_{stg}	Storage temperature	−55 to 150	°C
T_j	Max. operating junction temperature	150	°C
	DIN humidity category (DIN 40040)	E	
	IEC climatic category (DIN IEC 68-1)	55/150/56	

THERMAL DATA

$R_{thj\text{-}case}$	Thermal resistance junction-case	max	3.1	°C/W
$R_{thj\text{-}amb}$	Thermal resistance junction-ambient	max	75	°C/W

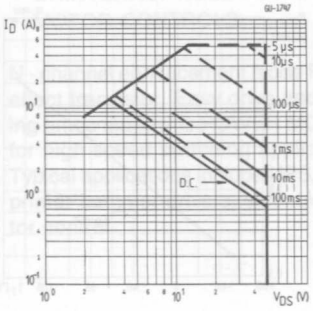
ELECTRICAL CHARACTERISTICS (T_j = 25°C unless otherwise specified)

Parameters		Test Conditions		Min.	Typ.	Max.	Unit
OFF							
$V_{(BR)\ DSS}$	Drain-source breakdown voltage	I_D = 250 μA	V_{GS} = 0	50			V
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating	 T_j = 125°C			250 1000	μA μA
I_{GSS}	Gate-body leakage current (V_{DS} = 0)	V_{GS} = ±20 V			-	±100	nA
ON							
$V_{GS\ (th)}$	Gate threshold voltage	V_{DS} = V_{GS}	I_D = 1 mA	2.1		4	V
$R_{DS\ (on)}$	Static drain-source on resistance	V_{GS} = 10 V	I_D = 9 A			0.12	Ω
DYNAMIC							
g_{fs}	Forward transconductance	V_{DS} = 25 V	I_D = 9 A	3			mho
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} = 25 V V_{GS} = 0	f = 1 MHz			650 450 280	pF pF pF
SWITCHING							
$t_{d\ (on)}$ t_r $t_{d\ (off)}$ t_f	Turn-on time Rise time Turn-off delay time Fall time	V_{DD} = 30 V R_{GS} = 50 Ω	I_D = 3 A V_{GS} = 10 V			30 85 90 110	ns ns ns ns

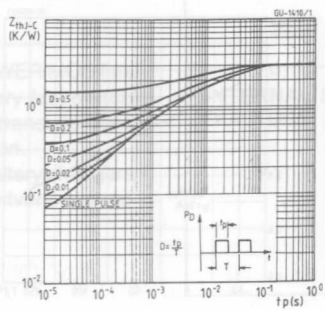
ELECTRICAL CHARACTERISTICS (Continued)

Parameters		Test Conditions		Min.	Typ.	Max.	Unit
SOURCE DRAIN DIODE							
I_{SD} I_{SDM}	Source-drain current Source-drain current (pulsed)	T_c = 25°C				13 52	A A
V_{SD}	Forward on voltage	I_{SD} = 26 A	V_{GS} = 0			2.2	V
t_{rr}	Reverse recovery time	I_{SD} = 13 A	di/dt = 100A/μs		120		ns
Q_{rr}	Reverse recovered charge				0.15		μC

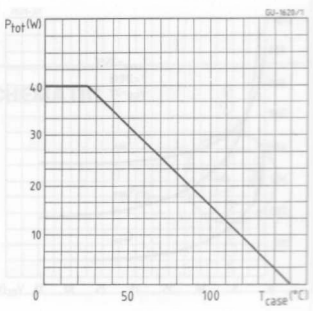
Safe operating areas



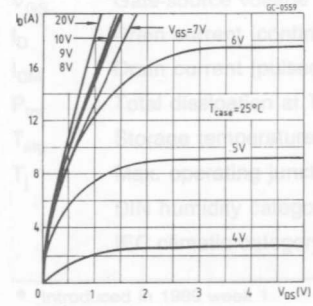
Thermal impedance



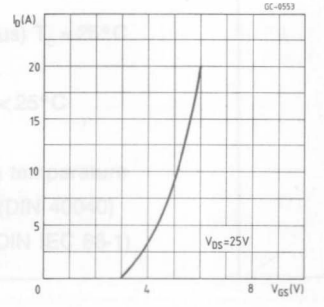
Derating curve



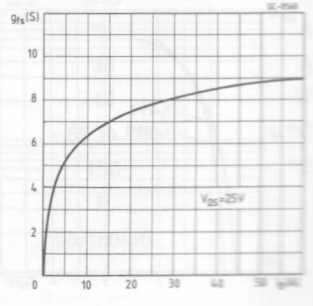
Output characteristics



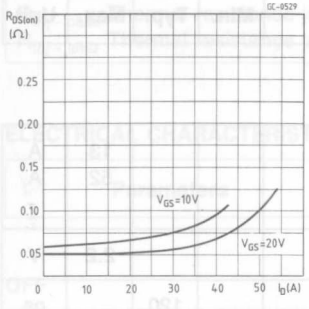
Transfer characteristics



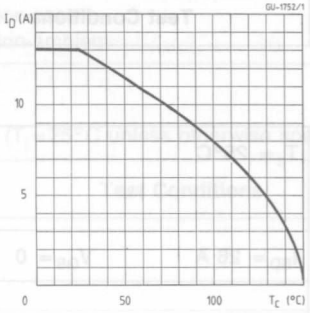
Transconductance



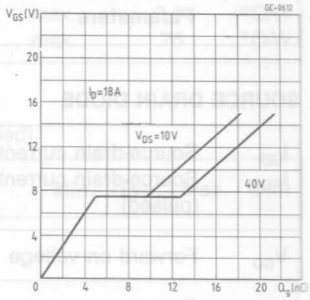
Static drain-source on resistance



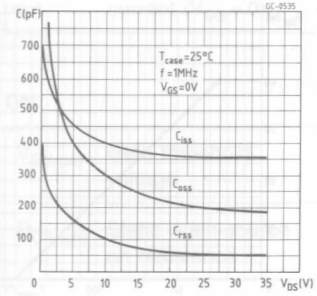
Maximum drain current vs temperature



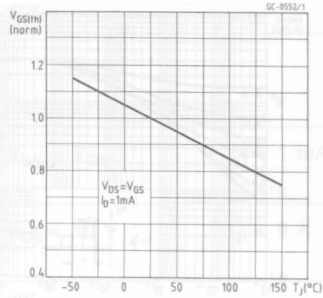
Gate charge vs gate-source voltage



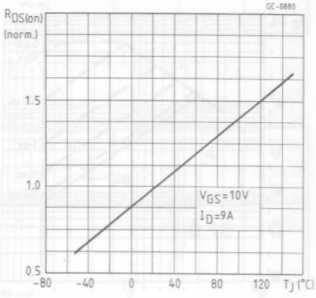
Capacitance variation



Gate threshold voltage vs temperature



Drain-source on resistance vs temperature



Source-drain diode forward characteristics